In Place of FORM PTO-1449 (Modified)

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE

Serial No. 10/046,940

Applicant: Barker, et. al. Filing Date: 1/14/2002

Group: 2179

ATEMENT Atty. Docket No. <u>RSW920010049US1</u> **U. S. PATENT DOCUMENTS** Classification Filing Date if xaminer Document Class / Subclass **Appropriate** <u>Initial</u> Number <u>Date</u> Name 5,257,371 10-1993 Anezaki 707/103R AA AB 5,870,611 02-1999 London Shrader et al. 717/175 09-1999 Hesse et al. AC 5,950,010 717/178 AD 6,199,195 03-2001 Goodwin et al. 717/104 **AE** 6,311,321 10-2001 Agnihotri et al. 717/120 AF 2002/002926 03-2002 Toyoshima et al. 709/223 AG 2003/005594 03-2003 Wang 709/224 AH 08-2002 705/1 2002/010366 Cramon et al. ΑI 2002/009181 07-2002 Melchione et al. 709/224 AJ 6,567,808 05-2003 Eschelbeck et al. 707/10 ΑK AL **FOREIGN PATENT DOCUMENTS** Examiner Document Translation **Initial** Number Country Classification Yes No **Date** AM AN A0 AP Examiner OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) AQ Schmidt "Using Design Patterns to Develop Reusable Object-Oriented Communication Software" 10/1995 Communications of the ACM Vol. 38, No. 10 pp. 65-74 AR Keller et al. "A Pattern System for Network Management Interfaces" 09/1998 Communications of the ACM Vol. 41 No. 9 AS "Common Information Model (CIM) Specification ver 2.2." June 14, 1999 DMTF. AT ΑU Examiner: Date Considered: EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if hot in conformance and not considered. Include copy of this form with next communication to

applicant.

LIST OF PATENTS AND PUBLICATIONS FOR Applicant: Barker, et. Filing Date: 1/14/2002
APPLICANT'S INFORMATION DISCLOSURE Group: 2170
STATEMENT

Applicant: Barker, et. al.

Filing Date: 1/14/2002

Atty. Docket No. RSW920010049US1

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<u>Initial</u>		Number	Date		<u>Name</u>		Class / Subclass	Appropriate 726
-03	AA	5,483,631	01-1996		Nagai et al.		715	736
	AB	5,566,294	10-1996		Kojima et al.		715	866
	AC	5,635,918	06-1997		Tett, Richard J.	•	340	7.29
	AD	5,754,173	05-1998		Hiura et al.		715	744
th	AE	5,907,696	05-1999		Stilwell et al.		703	13
<u>_///S</u>	AF	6,317,748	11-2001		Menzies et al.		707	103X
	AG							
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FOREIGN PATENT DOCUMENTS								
Examiner		Document						Translation
<u>Initial</u>		Number		<u>Date</u>	Count	try	Classification	Yes No
45	AM	JP 06168197 A		06-1994	Japa	n	G06F013/00	Yes (abstract)
	AN							
	AO							
	AP							•
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i/k	AQ	"WREM on Sun De	eveloner's	Guide " A	11011st 1000 Su	n Micro	systems, Chapters 1	2 and 4
-4-/	AR	W DEWY ON CUIT D	eveloper s	Guide, A	ugust 1777, Su	III 1VIICIO	systems, Chapters 1	, 2, and 4
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applicant.